

**INFORMATION DISCLOSURE STATEMENT
BY APPLICANT**

Attorney Docket Number	23-65037-01
Application Number	10/726,744
Filing Date	December 2, 2003
First Named Inventor	Larry C. Olsen
Art Unit	1795
Examiner Name	Jeffrey Thomas Barton

U.S. PATENT DOCUMENTS

Copies of U.S. Patent documents do not need to be provided, unless requested by the Patent and Trademark Office. For patents, provide the patent number and the issue date. For published U.S. applications, provide the publication number and the publication date. For unpublished pending patent applications, provide the application number and the filing date and submit a copy.

Examiner's Initials*	Cite No. (optional)	Number	Date	Name of Applicant or Patentee
		3,900,603	8/1975	Rittmayer et al.
		3,931,673	1/1976	Eggemann
		3,945,855	3/1976	Skrabek et al.
		4,036,665	7/1977	Barr et al.
		2003/0089391	5/2003	Fukudome et al.

FOREIGN PATENT DOCUMENTS

Examiner's Initials*	Cite No. (optional)	Country	Number	Date	Name of Applicant or Patentee
		EPC	0034538	8/1981	
		DE	6900274	8/1970	
		DE	2124465	11/1972	
		DE	2457586	6/1975	
		JP	7-7186	1/1995	
		JP	10-51037	2/1998	
		JP	2003-92432	3/2003	
		CH	677421	5/1991	
		WIPO	99/54941	10/1999	

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Examiner's Initials*	Cite No. (optional)	OTHER DOCUMENTS
		Kim, et al., "Effects of a Reduction Treatment and Te Doping Properties of (Bi _{1-x} Sbx)2Te ₃ Fabricated by Mechanical Alloying," <i>16th International Conference on Thermoelectrics</i> , pp. 127-130 (1997).
		Yamashita, O. et al., "Bismuth telluride compounds with high thermoelectric figures of merit," <i>Journal of Applied Physics</i> , Vol. 93, No. 1, pp. 368-374 (January 1, 2003).

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